

<b>Notice of References Cited</b>	Application/Control No. 10/726,821	Applicant(s)/Patent Under Reexamination FUKUI, KENJI	
	Examiner Marissa J. Detschel	Art Unit 2877	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,266,147	07-2001	Naulleau, Patrick	356/515
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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